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EXAMINER

HANNAHER, CONSTANTINE

ART UNIT	PAPER NUMBER
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2878

DATE MAILED: 10/14/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

# Office Action Summary

Application No.

09/683,738

Applicant(s)

VAFI ET AL.

Examiner

Constantine Hannaher

Art Unit

2878

A.W.

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

## Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

## Status

- 1) ☒ Responsive to communication(s) filed on 19 September 2003.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

## Disposition of Claims

- 4) ☒ Claim(s) 1-36 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☒ Claim(s) 19-36 is/are allowed.
- 6) ☒ Claim(s) 1-18 is/are rejected.
- 7) ☐ Claim(s) \_\_\_\_\_ is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

## Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on \_\_\_\_\_ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) ☐ The proposed drawing correction filed on \_\_\_\_\_ is: a) ☐ approved b) ☐ disapproved by the Examiner.
- If approved, corrected drawings are required in reply to this Office action.
- 12) ☐ The oath or declaration is objected to by the Examiner.

## Priority under 35 U.S.C. §§ 119 and 120

- 13) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some \* c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- \* See the attached detailed Office action for a list of the certified copies not received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) ☐ The translation of the foreign language provisional application has been received.
- 15) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

## Attachment(s)

- 1) ☐ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449) Paper No(s) \_\_\_\_\_
- 4) ☐ Interview Summary (PTO-413) Paper No(s). \_\_\_\_\_
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: \_\_\_\_\_

## DETAILED ACTION

### Claim Rejections - 35 USC § 103

1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

2. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).
3. Claims 1 and 2 are rejected under 35 U.S.C. 103(a) as being unpatentable over Crawford *et al.* (US005970113A) in view of Nakagawa *et al.* (JP04315985A).

With respect to independent claim 1, Crawford *et al.* discloses a method for determining the temperature of a detector panel **130** having a plurality of photodiodes (column 11, line 49) in an x ray imaging system (*e.g.*, Fig. 4) at the time an x ray image is taken which comprises the steps of measuring an offset image value for at least one of the plurality of photodiodes of the detector panel **130** taken for at least two known temperatures without x ray (column 17, lines 54-56), extrapolating an offset image value versus temperature curve for each of the measured offset image values for each of the plurality of photodiodes (in view of the temperature dependence characterization, also

described as a "function," see column 17, lines 61-67), and storing the curve within a processing circuit **134** coupled within the x ray imaging system. However, the method of Crawford *et al.* determines the temperature of the detector panel **130** using a sensor **521**. Nakagawa *et al.* shows (Fig. 1) that it is long known to determine the temperature of a photoelectric transfer element **101** in an x ray detection system by measuring an offset value taken without an x ray (and stored in element **109**) and comparing it using a predetermined equation to stored data regarding offset and temperature characteristics. Since an external sensor is not required and the construction of the system is simplified, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the method of Crawford *et al.* to specify that processing circuit **134** determined the temperature of the detector panel **130** by measuring a second offset image value taken without an x ray for at least one of the plurality of photodiodes as suggested by Nakagawa *et al.*

With respect to dependent claim 2, the measurement "before actual scanning" as taught by Crawford *et al.* is a range which encompasses the recited time which is sufficient to anticipate or make obvious the recited time.

4. Claims 3-18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Crawford *et al.* (US005970113A) in view of Nakagawa *et al.* (JP04315985A) and Sasaki *et al.* (US006411672B1).

With respect to independent claim 3, the measuring, extrapolating, storing, and determining steps are suggested by Crawford *et al.* and Nakagawa *et al.* as explained above in the rejection of independent claim 1. While the method of Crawford *et al.* does not comprise the direct control of temperature of the detector panel **130**, Sasaki *et al.* teaches that, in an x ray imaging system (Fig. 5) comprising a detector panel **25** having a plurality of solid state detection elements, the provision of a coldplate **42** and a conditioner unit **41** fluidically coupled **43** with the coldplate is known. The

conditioner unit **41** in the system of Sasaki *et al.* is capable of maintaining the detector panel **25** within an operating temperature range. Since the photodiodes in the method of Crawford *et al.* will experience the difficulties Sasaki *et al.* describes for solid-state detection elements at column 1, lines 39-50, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the method of Crawford *et al.* to comprise the step of providing a coldplate and conditioner as suggested by Sasaki *et al.* in order to avoid the problem of temperature nonuniformity. The closed-loop cooling system suggested by Sasaki *et al.* is controlled (column 5, lines 38-40). In view of the desire to avoid the problem of temperature nonuniformity described by Sasaki *et al.* it would have been obvious to one of ordinary skill in the art at the time the invention was made to electrically couple the processing circuit **134** of Crawford *et al.* with the conditioner suggested by Sasaki *et al.* in order to control the degree of heating and cooling. Although the method of Crawford *et al.* uses sensor **521** to determine the temperature of the detector panel, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the method of Crawford *et al.* to specify that processing circuit **134** directed a signal to the conditioner unit suggested by Sasaki *et al.* on the basis of the temperature of the detector panel **130** determined by the suggestion of Nakagawa *et al.* to effect the control Sasaki shows is beneficial while omitting the sensors otherwise required by Crawford *et al.*

With respect to dependent claim 4, it would have been obvious to one of ordinary skill in the art at the time the invention was made that the electrical signal from processing circuit **134** of Crawford *et al.* to the conditioner unit **41** suggested by Sasaki *et al.* would effect any control of the apparatus suggested by Sasaki *et al.* in view of the multiple elements and the "the degree of heating and cooling" desired.

With respect to dependent claim 5, the measurement "before actual scanning" as taught by Crawford *et al.* is a range which encompasses the recited time which is sufficient to anticipate or make obvious the recited time.

With respect to dependent claims 6, 7, 8, and 9 (as best understood), one of ordinary skill in the art must be presumed to know the manner of control suggested by Sasaki *et al.* (column 5, lines 38-40) and the recited procedures would have been obvious to one of ordinary skill in the art at the time the invention was made in view of the "arbitrary type of coolant" and the control of "the degree of heating and cooling" described by Sasaki *et al.*

With respect to independent claim 10, Nakagawa *et al.* discloses a method comprising the steps of determining an amount of dark current (another name for leakage) exhibited by at least one photoelectric transfer element **101** immediately prior to x ray exposure. Crawford *et al.* teaches that it is typical for the photoelectric transfer element to be a photodiode (column 11, line 49) so it would have been obvious to one of ordinary skill in the art at the time the invention was made to specify that the element **101** in the method of Nakagawa *et al.* was a photodiode in view of the effective performance in detecting x rays (both methods operate through the intermediary of a scintillator or fluorescent substance) and further that the element **101** was one of a plurality in view of the detector array **130** of Crawford *et al.* offering simultaneous reception of x rays in an x ray imaging system. While the systems of Nakagawa *et al.* and Crawford *et al.* do not have a conditioner unit or a coldplate, Sasaki *et al.* teaches that, in an x ray imaging system (Fig. 5) comprising a detector panel **25** having a plurality of solid state detection elements, the presence of a coldplate **42** and a conditioner unit **41** within the system is known. Since the photoelectric transfer elements **10** in the method of Nakagawa *et al.* and the photodiodes in the method of Crawford *et al.* will experience the difficulties Sasaki *et al.* describes for solid-state detection elements at column 1, lines 39-50, it would have been

obvious to one of ordinary skill in the art at the time the invention was made to modify the method suggested by Nakagawa *et al.* and Crawford *et al.* to comprise the step of controlling (column 5, lines 38-40) a conditioner unit and a coldplate as suggested by Sasaki *et al.* in order to avoid the problem of temperature nonuniformity. One of ordinary skill in the art must be presumed to know the manner of control suggested by Sasaki *et al.* (column 5, lines 38-40) and the recited procedure would have been obvious to one of ordinary skill in the art at the time the invention was made in view of the "arbitrary type of coolant" and the control of "the degree of heating and cooling" described by Sasaki *et al.*

With respect to dependent claim 11, the measuring, extrapolating, storing, and determining steps are suggested by Crawford *et al.* and Nakagawa *et al.* as explained above in the rejection of independent claim 1.

With respect to independent claim 12, Crawford *et al.* discloses an x ray imaging system (*e.g.*, Fig. 4) comprising a detector panel **130** having a plurality of photodiodes (column 11, line 49) and a processing circuit **134** electrically coupled with at least one of the plurality of photodiodes. While the system of Crawford *et al.* does not comprise a closed-loop cooling system, Sasaki *et al.* teaches in an x ray imaging system (Fig. 5) comprising a detector panel **25** having a plurality of solid state detection elements that the presence of a coldplate **42** closely coupled with the detector panel and a conditioner unit **41** fluidically coupled **43** with the coldplate is known. The conditioner unit **41** in the system of Sasaki *et al.* is capable of maintaining the detector panel **25** within an operating temperature range. Since the photodiodes in the system of Crawford *et al.* will experience the difficulties Sasaki *et al.* describes for solid-state detection elements at column 1, lines 39-50, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the system of Crawford *et al.* to comprise a coldplate and conditioner as suggested by Sasaki *et al.* in

order to avoid the problem of temperature nonuniformity. The closed-loop cooling system suggested by Sasaki *et al.* is controlled (column 5, lines 38-40). The system of Crawford *et al.* determines the temperature of the detector panel **130** using a sensor **521**. In view of the desire to avoid the problem of temperature nonuniformity described by Sasaki *et al.* it would have been obvious to one of ordinary skill in the art at the time the invention was made to electrically couple the processing circuit **134** of Crawford *et al.* with the conditioner suggested by Sasaki *et al.* in order to control the degree of heating and cooling. Although the system of Crawford *et al.* uses sensor **521** to determine the temperature of the detector panel, Nakagawa *et al.* shows (Fig. 1) that it is long known to determine the temperature of a photoelectric transfer element **101** in an x ray detection system as a function of the amount of dark current (measured and stored in element **109**) generated. Since an external sensor is not required and the construction of the system is simplified, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the system of Crawford *et al.* to specify that processing circuit **134** produced a signal representing the temperature of the detector panel **130** by measuring the amount of dark current generated by at least one of the plurality of photodiodes as suggested by Nakagawa *et al.*

With respect to dependent claim 13, the system of Crawford *et al.* has a stored offset value versus temperature curve (column 18, lines 6-8). Nakagawa *et al.* shows that measuring an offset value of the photoelectric transfer element without an x ray prior to acquiring an x ray and converting the offset value to a temperature value using an equation and the stored data of offsets and temperatures (see Constitution) is known. It would have been obvious to one of ordinary skill in the art at the time the invention was made to specify that the processing circuit **134** of Crawford *et al.* determined the temperature of the detector panel **130** by the measurement sequence suggested by Nakagawa *et al.* in view of the elimination of the temperature sensor **521**.



With respect to dependent claim 14, the system of Crawford *et al.* measures and stores the offset image values in the manner recited (column 17, lines 51-57). Process limitations cannot serve to impart patentability to structures. *In re Dike*, 157 USPQ 581, 585 (CCPA 1968). Methods of making a claimed product are immaterial in a product claim in view of *In re Thorpe*, 777 F.2d 695, 227 USPQ 964 (Fed. Cir. 1985) and *In re Brown*, 459 F.2d 531, 173 USPQ 685 (CCPA 1972). It is axiomatic that the additional presence of process limitations, no matter how detailed, cannot impart patentability to a product. *In re Pilkington*, 411 F.2d 1345, 162 USPQ 145 (CCPA 1969); *In re Johnson*, 394 F.2d 591, 157 USPQ 620 (CCPA 1968); and *In re Stephen*, 345 F.2d 1020, 145 USPQ 656 (CCPA 1965). Accordingly, the time of the measurement and storage is not a limitation on the system. Nevertheless, "before actual scanning" as taught by Crawford *et al.* is a range which encompasses the recited time which is sufficient to anticipate or make obvious the recited time.

With respect to dependent claims 15-18, one of ordinary skill in the art must be presumed to know the manner of control suggested by Sasaki *et al.* (column 5, lines 38-40) and the recited procedures would have been obvious to one of ordinary skill in the art at the time the invention was made in view of the "arbitrary type of coolant" and the control of "the degree of heating and cooling" described by Sasaki *et al.*

#### **Response to Submission(s)**

5. The amendment filed September 19, 2003 has been entered.
6. Applicant's arguments, see page 13, filed September 19, 2003, with respect to claims 8 and 9 have been fully considered and are persuasive. The rejection of claims 8 and 9 on the basis of 35 U.S.C. 112 has been withdrawn.
7. Applicant's arguments filed September 19, 2003 have been fully considered but they are not persuasive.

In response to applicant's arguments against the references individually, one cannot show nonobviousness by attacking references individually where the rejections are based on combinations of references. See *In re Keller*, 642 F.2d 413, 208 USPQ 871 (CCPA 1981); *In re Merck & Co.*, 800 F.2d 1091, 231 USPQ 375 (Fed. Cir. 1986).

Since the method of Nakagawa *et al.* measures an offset value immediately prior to use of the x ray system, the rote rebuttal of the rejection as found, for example, at page 15 of the submission is not persuasive. The claim scope is to determination immediately prior to *or* immediately after and it is sufficient that the art suggest one or the other and it is not a requirement that the art suggest both. Furthermore, the suggested measurement of an offset value becomes an "second" offset value when compared to the measurement of a first offset value by the method of Crawford *et al.*

In response to applicant's argument that the examiner's conclusion of obviousness is based upon improper hindsight reasoning, it must be recognized that any judgment on obviousness is in a sense necessarily a reconstruction based upon hindsight reasoning. But so long as it takes into account only knowledge which was within the level of ordinary skill at the time the claimed invention was made, and does not include knowledge gleaned only from the applicant's disclosure, such a reconstruction is proper. See *In re McLaughlin*, 443 F.2d 1392, 170 USPQ 209 (CCPA 1971).

The utter absence of acknowledgment, consideration, or rebuttal of the Examiner's explanation as to why it would have been obvious for one of ordinary skill in the art to replace the temperature determination step of Crawford *et al.* with the temperature determination step of Nakagawa *et al.* when both disclosures are to photoelectric transfer elements in an x ray detection system is not responsive.

That the method of Sasaki *et al.* may be more capable by offering both heating and cooling as necessary is not a valid rebuttal. Furthermore, it must be true that "the degree of heating or

cooling can be controlled by adjusting the compression ratio of the compressor" (Sasaki *et al.* at column 5, lines 38-40) works entirely differently from control of temperature or flow for applicant's argument to prevail. Yet it is elementary knowledge that compression and expansion have known effects on temperature and flow.

For at least the reasons explained above, Applicant is not entitled to a favorable determination of patentability in view of the arguments submitted September 19, 2003.

#### **Allowable Subject Matter**

8. Claims 19-36 are allowed.

9. The following is a statement of reasons for the indication of allowable subject matter: Nakagawa *et al.* determines the temperature of the detector panel immediately before X-ray exposure, but apparently not after such exposure.

#### **Conclusion**

10. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Art Unit: 2878


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11. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Constantine Hannaher whose telephone number is (703) 308-4850. The examiner can normally be reached on Monday-Friday with flexible hours.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David P. Porta can be reached on (703) 308-4852. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

ch

  
Constantine Hannaher  
Primary Examiner